

3N246

MINIATURE INTEGRAL DIODE ASSEMBLIES

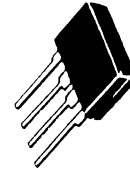
... with silicon rectifier chips interconnected and encapsulated into voidless rectifier bridge circuits.

- High Resistance to Shock and Vibration
- High Dielectric Strength
- Built-In Printed Circuit Board Stand-Offs
- UL Recognized
- RO<sub>JA</sub> = 60°C/W



SINGLE-PHASE  
 FULL-WAVE BRIDGE

1.0 AMPERE  
 50-1000 VOLTS



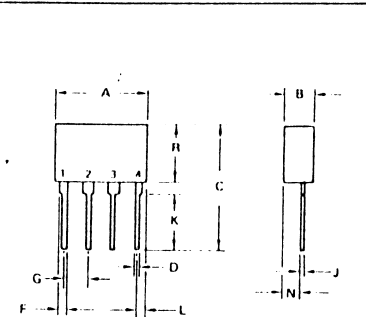
MAXIMUM RATINGS		3N246		Unit
Rating (Per Diode)	Symbol			
Peak Repetitive Reverse Voltage	V <sub>RRM</sub>	50		Volts
Working Peak Reverse Voltage	V <sub>RWM</sub>			
DC Blocking Voltage	V <sub>R</sub>			
DC Output Voltage	V <sub>dc</sub>	32		Volts
Resistive Load	V <sub>dc</sub>	50		Volts
Capacitive Load	V <sub>dc</sub>			
Sine Wave RMS Input Voltage	V <sub>R(RMS)</sub>	35		Volts
Average Rectified Forward Current (single phase bridge operation, resistive load, 60 Hz, T <sub>A</sub> = 75°C)	I <sub>O</sub>	1.0		Amp
Non-Repetitive Peak Surge Current (Preceded and followed by rated current and voltage, T <sub>A</sub> = 75°C)	I <sub>FSM</sub>	30 (for 1 cycle)		Amp
Operating and Storage Junction Temperature Range	T <sub>J</sub> , T <sub>stg</sub>	-55 to +150		°C

ELECTRICAL CHARACTERISTICS

Characteristic	Symbol	Typ	Max	Unit
Instantaneous Forward Voltage (Per Diode) (I <sub>F</sub> = 1.57 Amp, T <sub>J</sub> = 25°C)	v <sub>F</sub>	1.15	1.3	Volts
Reverse Current (Per Diode) (Rated V <sub>R</sub> , T <sub>A</sub> = 25°C)	I <sub>R</sub>		10	µA

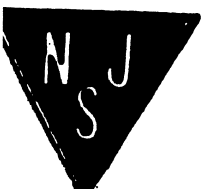
MECHANICAL CHARACTERISTICS

CASE: Transfer Molded Plastic	MOUNTING POSITION: Any
POLARITY: Terminal-designation on case	WEIGHT: 1.8 grams (approx)
Pin 1 (+) for DC output	TERMINALS: Readily solderable
Pin 4 (-) for DC output	connections, corrosion resistant.
Pins 2 and 3 (AC) for AC input	



STYLE 1  
 TERM 1 POS  
 2 AC  
 3 AC  
 4 NEG

DIM	MILLIMETERS		INCHES	
	MIN	MAX	MIN	MAX
A	14.99	15.49	0.590	0.610
B	4.57	5.08	0.180	0.200
C		20.57		0.810
D	0.76	1.02	0.030	0.040
F	1.02	1.27	0.040	0.050
G	3.68	3.94	0.145	0.155
J	0.56	0.71	0.022	0.028
K		9.02		0.355
L	1.78	2.03	0.070	0.080
N	2.54	2.79	0.100	0.110
R	9.40	10.03	0.370	0.395



**ELECTRICAL CHARACTERISTICS**

 (T<sub>A</sub> = 25°C unless otherwise noted.)

Characteristic		Symbol	Min	Max	Unit
Common Source Power Gain (V <sub>DD</sub> = 18 Vdc, V <sub>GG</sub> = 7.0 Vdc, f = 200 MHz) (V <sub>DD</sub> = 24 Vdc, V <sub>GG</sub> = 6.0 Vdc, f = 45 MHz) (V <sub>DD</sub> = 24 Vdc, V <sub>GG</sub> = 6.0 Vdc, f = 45 MHz) (V <sub>DD</sub> = 18 Vdc, f <sub>LO</sub> = 245 MHz, f <sub>RF</sub> = 200 MHz)	3N211	G <sub>ps</sub>	24	35	dB
	3N211		29	37	
	3N213	27	35		
	3N212	21	28		
Bandwidth (V <sub>DD</sub> = 18 Vdc, V <sub>GG</sub> = 7.0 Vdc, f = 200 MHz) (V <sub>DD</sub> = 18 Vdc, f <sub>LO</sub> = 245 MHz, f <sub>RF</sub> = 200 MHz) (V <sub>DD</sub> = 24 Vdc, V <sub>GG</sub> = 6.0 Vdc, f = 45 MHz)	3N211	BW	5.0	12	MHz
	3N212		4.0	7.0	
	3N211,213		3.5	6.0	
Gain Control Gate-Supply Voltage(5) (V <sub>DD</sub> = 18 Vdc, ΔG <sub>ps</sub> = -30 dB, f = 200 MHz) (V <sub>DD</sub> = 24 Vdc, ΔG <sub>ps</sub> = -30 dB, f = 45 MHz)	3N211	V <sub>GG(GC)</sub>	—	-2.0	Vdc
	2N211,213		—	±1.0	

(1) Measured after five seconds of applied voltage.

(2) All gate breakdown voltages are measured while the device is conducting rated gate current. This ensures that the gate-voltage limiting network is functioning properly.

(3) Pulse Test: Pulse Width = 300 μs, Duty Cycle ≤ 2.0%.

(4) This parameter must be measured with bias voltages applied for less than 5 seconds to avoid overheating. The signal is applied to gate 1 with gate 2 at ac ground.

 (5) ΔG<sub>ps</sub> is defined as the change in G<sub>ps</sub> from the value at V<sub>GG</sub> = 7.0 Volts (3N211) and V<sub>GG</sub> = 6.0 Volts (3N213).

 (6) Power Gain Conversion. Amplitude at input from local oscillator is adjusted for maximum G<sub>c</sub>.